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14:00 - 16:00	Methodology (Work-in-Progress, poster session, Chair: Roberto Passerone)
	<p> <u>"Compositional Translation of Simulink Models into Synchronous BIP"</u> <papers tf-000353.pdf)<br=""></papers> Vassiliki Sfyrla, Georgios Tsiligiannis, Iris Safaka, Marius Bozga, Joseph Sifakis </p> <p> <u>"Design and Implementation of a WirelessHART Simulator for Process Control"</u> (papers/TF-000418.pdf) Kunjesh Shah, Tiberiu Seceleanu, Mikael Gidlund </p> <p> <u>"L2 Cache Modeling based on address modification for Native Co-Simulation in SystemC"</u> (papers/TF-000493.pdf) Sara Real, Hector Posadas, Eugenio Villar </p> <p> <u>"A Design Flow for Critical Embedded Systems"</u> (papers/TF-000965.pdf) Vincent Lefftz, Jean Bertrand, Hugues Cassé, Christophe Clienti, Philippe Coussy, Laurent Maillet-Contoz, Philippe Mercier, Pierre Moreau, Laurence Pierre, Emmanuel Vaumorin </p> <p> <u>"Design and implementation of a suitable core for on-chip long-term verification"</u> (papers/TF-001007.pdf) Julian Viejo, Jose Ignacio Villar, Jorge Juan, Alejandro Millan, Manuel Jesus Bellido, Enrique Ostua </p>

Design and implementation of a suitable core for on-chip long-term verification

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Abstract—Traditional on-chip and off-chip logic analyzers present important shortcomings when used for the long-term verification of industrial embedded systems, forcing the designer to implement ad-hoc verification solutions. This contribution presents a suitable solution for long-term verification of FPGA-based designs consisting on a verification core that uses the Picoblaze microcontroller, dedicated logic and a serial port communication in order to monitor the internal signals of the system in a continuous way. The core design focuses on low resource requirements and reusability and has been successfully applied to the verification of a real industrial synchronization platform showing remarkable advantages over commercial on-chip solutions like Xilinx's ChipScope Pro.

I. INTRODUCTION

Over the past decade, FPGAs has become the major implementation technology for industrial embedded digital systems due to its fast prototyping, short time-to-market and increasing capabilities. The always reducing cost of FPGAs make them suitable not only during the prototype phase but also for low and medium volume production. The re-programmability of FPGA chips is also very valuable during the design and production phases of the system allowing for easier verification, debugging and support of the systems.

FPGA verification can be done by simulation and hardware execution [1]–[3]. Simulation is specially useful during the first stages of the design flow to assure the correct operation of the systems. But there are scenarios where simulation is not a feasible approach, like the verification of a whole complex system, because the simulation time would be extremely huge and/or computational resources may be exhausted. In this cases, hardware execution is an interesting alternative derived from the re-programmable nature of FPGAs that permits the observation of the design under study in real time during its operation. Such observations are taken in several ways including external and on-chip logic analyzers. On-chip logic analyzers like Chipscope [4] are able to acquire data at a very high frequency and store the results in memory for later processing, so data acquisition is limited by the storage resources available in the chip [5], [6].

While the above mentioned limitation is not a serious problem for the verification of many types of systems, it is important to note that on-chip logic analyzers share the resources with the system under test and may consume an

important part of the area available, requiring significantly more resources during verification than in the final production system.

A special case is the verification of the correct long-term operation of a system. This is specially useful to test the robustness of the implementation in industrial aggressive environments where systems are supposed to operate continuously for months or years. In this case, the collection of data from internal signals over a long period of time should be possible. These data should be communicated to the outside of the chip in order to avoid large internal storage resources (that would be exhausted over time) and to allow for the continuous monitoring of the system.

Neither on-chip or off-chip solutions fit well to do this kind of long-term verification so designers typically have to develop custom solutions (test logic and tools) for each design. A good example is a network synchronization system remote terminal units previously developed by the authors [7] where internal data need be collected every few seconds for a period of days or even months.

This contribution presents a more general solution for long-term verification of digital systems implemented on FPGA that can be adapted to several problems to avoid the cost of designing custom verification logic. The proposed solution takes the form of a test core based on the Picoblaze microcontroller and associated tools that can greatly facilitates long term verification of complex systems with minimal resources or external equipment requirements when compared to on-chip or off-chip logic analyzers.

The paper is organized as follows: in section two an outline of common verification tools is presented from the point of view of their applicability to scattered event acquisition and analysis, section three describes the architecture of the proposed long-term on-chip data acquisition core, in section four the proposed solution and the commercial ChipScope Pro test system are compared against a real application and, finally, section five summarizes the most relevant conclusions derived from this experience.

II. CURRENT SOLUTIONS FOR SYSTEM VERIFICATION

Currently there are three main types of solutions when approaching digital system verification: standalone logic ana-

lyzers, on-chip logic analyzers and custom cores for specific purposes. In this section we will highlight the main features, advantages and disadvantages of each one from the perspective of their applicability to long-term verification.

Standalone Logic Analyzers (SLAs) are very powerful tools for debugging an already implemented design. This kind of equipment is able to acquire data at a very high frequency from any signal that can be accessed at the pins of the chip. Moreover, they may have a large number of channels (100 or more) that makes them a very useful tool for debugging high speed buses and signals between components. The main disadvantage of SLAs is that they cannot reach signals inside the design. To overcome this issue, designs are modified in order to route the desired signals to external pins accessible by the SLA thus modifying the characteristics and timing parameters of the original design.

An evolution of SLAs are On-chip Logic Analyzers (OLAs) like Xilinx's ChipScope, that have become very popular in the field of programmable logic. This kind of analyzers are hardware components that connect to the desired signals inside the chip and communicate over a standard bus (usually RS232 or JTAG) with a computer that executes software for data analysis. These components are an intrusive solution since the verified design is different from the production design when analysis components are removed.

These two types of verification tools have a common denominator: the limit of the capture size is given by the size of the storage memory since they store a complete capture frame before sending it to the processing unit.

Some tests require to capture some kind of events from within the system continuously. To capture these events, developers usually create custom debugging cores (CDCs) for every specific purpose when SLAs or OLAs do not fulfill the verification requirements [8], [9].

III. LOGICAL EVENT ANALYZER

A. Architecture of the Logical Event Analyzer designed

To overcome the cost of designing a CDC for every application, we propose a general purpose device, the Logical Event Analyzer (LEA), that can fill the gap between SLA and OLA and substitute CDC in several practical cases. As it can be observed in Fig. 1, SLAs and OLAs are used to verify high-speed systems where the number of samples is not a critical aspect. However, LEA can be used for debugging systems where it is necessary to capture a large number of samples spaced in the time. The LEA also features a much lower footprint than an OLA.

The architecture of the proposed analyzer is based on the PicoBlaze microprocessor from Xilinx [10]. Fig. 2 shows the block diagram of the designed analyzer. As it can be observed from the diagram, a set of input ports of PicoBlaze are reserved for trigger, clock and communication control signals. The remaining ports are dedicated to capturing data signals. PicoBlaze allows for the addressing of 256 8-bit ports. Thus, using a single PicoBlaze module and dedicating N ports to trigger, clock and control signals the analyzer can

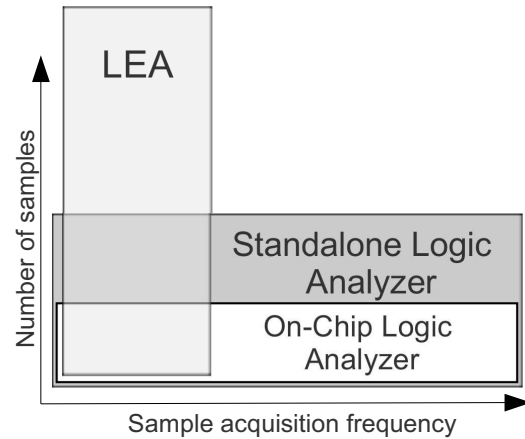


Fig. 1. Field of applicability of several verification solutions.

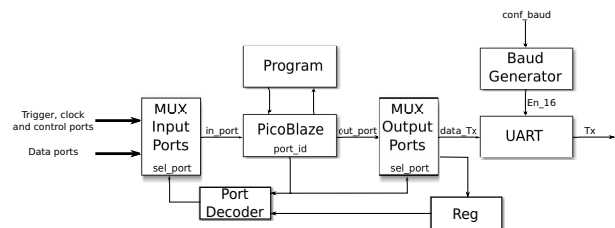


Fig. 2. Architecture of the designed analyzer.

capture $(256 - N) \times 8$ bit signals. If it is necessary to capture more signals a simple solution is to add an external n bits register to extend the port selection signal $port_id$. By using this alternative, the maximum number of signals that can be sampled would be $(256 - N) \times 2^n \times 8$. The number of data signals that can be acquired is also limited by the rate at which captured data can be transmitted out of chip as we will discuss later.

PicoBlaze uses one of their output ports to communicate with an UART that is in charge of transmitting the captured data via serial. The UART has a *half_full_buffer* signal which indicates that the FIFO is half full, and its baud rate can be set as needed. PicoBlaze will use the *half_full_buffer* signal to control the data transmission to the UART. Assuming the following UART configuration: fixed data format "8N1" (8 data bits, 1 stop bit and no parity), communication through the RX and TX signals (no other signals needed), and flow control disabled, the maximum bit rate (bps) that can be obtained is calculated according to (1).

$$BitRate = \frac{BaudRate * 8}{10} \quad (1)$$

Finally, the program module corresponds to the program that will be run by PicoBlaze. This program performs the following tasks:

- 1) Trigger condition verification. PicoBlaze reads the ports assigned to the trigger signals and applies the configured logical function. In the case this condition is verified,

data acquisition begins.

- 2) Data acquisition according to the clock signal. The clock signal corresponds to an event of the designed system, so that whenever this event occurs PicoBlaze starts to read the data connected to the input ports.
- 3) Data processing and transmission. This processing consists of calculating a checksum of the transmitted data so that the receiver can verify the correct reception of information. Data will be sent to the UART.
- 4) Communication control. Periodically, the microprocessor will check the status of *half_full_buffer* signal. If it is active PicoBlaze will wait for the FIFO to become half empty before sending more data.

IV. APPLICATION EXAMPLE AND RESULTS

In this section we describe the application of the LEA to the on-chip verification of a SNTP client and server fully implemented in hardware. SNTP is a simplified version of the more general Network Time Protocol (NTP) [11] that is commonly used for synchronizing the clocks of computer systems over data networks such as the Internet. The operation of this protocol is to send periodic time requests to a server synchronized with an accurate time source like a GPS receiver at request intervals that can vary from a few seconds to several minutes. When the server reply is received, the client uses a set of timestamps to calculate the round trip time and the time offset between the client's and server's clocks.

The client can then adjust its local clock based on these calculations. In a typical scenario, the client will be accurately synchronized to the server only after several request-response cycles. Since the time between requests can vary from a few seconds to several minutes the most important aspect in the testing analysis of these systems is not the speed at which samples are acquired but to capture a large number of system events, covering a wide time interval.

On-chip verification tools like ChipScope Pro feature high frequency sampling which allow the testing of high-speed buses and systems, but they face some limitations regarding the maximum number of samples that can be obtained from the system. This is mainly due to: 1) internal resources of the FPGA are used to store the samples, and 2) some of these resources, depending on the type of programmable device used, are often limited. The number of LUTs, FFs and BRAMs used by ChipScope depending on the number of signals and the number of samples are shown in Figures 3, 4, and 5, respectively. As it can be observed from Figures 3 and 4, LUTs and FFs depend mainly on the number of signals. However, Figure 5 shows that the main problem when performing on-chip verification using such tools is that the number of BRAMs used is directly proportional the number of signals and the number of samples. Furthermore, an additional BRAM must be included for each added Integrated Logic Analyzer (ILA) since each ILA only can capture a maximum of 256 signals. The total number of BRAMs is calculated according to (2). Thus, considering that BRAMs are the most limited resource and fixing a number of signals to capture, this type

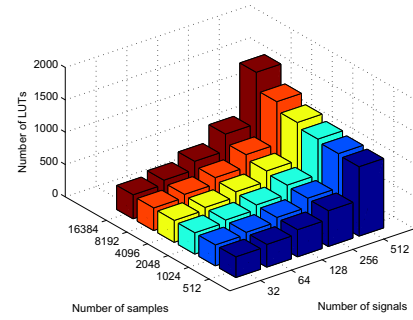


Fig. 3. Number of LUTs dependency on number of signal and samples using ChipScope.

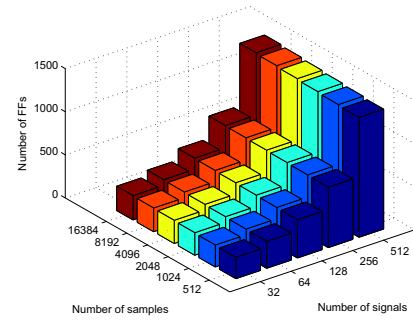


Fig. 4. Number of FFs dependency on number of signal and samples using ChipScope.

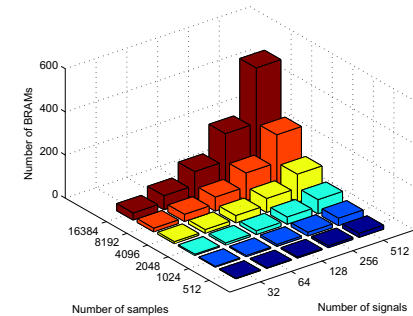


Fig. 5. Number of BRAMs dependency on number of signal and samples using ChipScope.

of simulation is unfeasible if the goal is to capture a large number of samples.

$$NumBRAMs = \left\lceil \frac{NumSignals \times NumSamples}{BRAMsize(bits)} \right\rceil + NumILAs \quad (2)$$

For the case under discussion, the SNTP client and server have been implemented on a Spartan-3E FPGA device (xc3s500e). These FPGAs have a total of 20 BRAMs and each

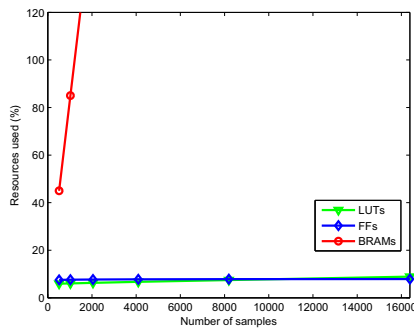


Fig. 6. Percentage of used resources dependency on the number of samples for 256 signals using ChipScope.

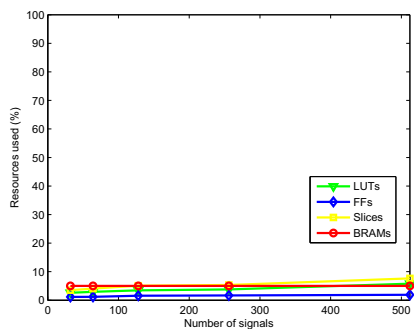


Fig. 7. Percentage of used resources dependency on the number of signals using LEA.

block contains 18,432 bits of fast static RAM, with 16 Kbit allocated for data storage. For each design a total of 256 signals have been sampled: timestamps (least significant part), time offset, round trip time and adjustment parameter of the local clock. With this configuration, the percentage of used resources (LUTs, FFs and BRAMs) to verify the system in terms of number of samples is shown in Figure 6. As shown in that figure, the LUT and FF usage is not critical, since it is a 9% and 8% respectively of total resources in the worst case. However, there is an excessive use of BRAMs even for a small number of samples. A maximum of 1024 samples can be captured which is insufficient for the type of system that is intended to verify.

The developed LEA has the advantage that it does not store data in BRAM but transmits them via serial. Therefore the number of BRAMs used to verify the system does not depend on the number of signals or the number of samples so the system can be tested indefinitely, only limited by external resources. For the rest of the FPGA resources, they become solely dependent on the number of signals (Fig. 7). For the same scenario presented for ChipScope (sampling of 256 signals) the percentage used of LUTs, FFs, Slices and BRAMs has been 3,79%, 1,68%, 5,35% and 5% respectively. It is worth noting that only a BRAM is used (this memory stores the program that will be run by PicoBlaze).

V. CONCLUSION

In this contribution, a verification core based on PicoBlaze for long-term on-chip verification is presented. The proposed solution allow developers to avoid the implementation of custom verification cores in many cases, greatly improving the design and verification time.

The proposed solution has been compared to ChipScope Pro on-chip logic analyzer in the verification of a real synchronization system. The results show that the ChipScope Pro tool is not suitable to verify the system because this would need excessive internal resources to store the captured data even for a small number of samples to acquire. The proposed core does not store data using internal resources but transmits them via serial port, so the system can be verified indefinitely, only limited by external computer storage.

Future work involves the replacement of PicoBlaze with an open source multivendor microcontroller, the development of a high speed interface to wider the range of applications and the study of more complex and flexible triggering possibilities.

ACKNOWLEDGMENT

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